



## Change of Assembly location: VCNT2020 (Reflective sensor)

For further information, please contact your regional Vishay office.

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**Description of Change:** Currently our VCNT2020 is assembled at Krubong Malaysia and this will be transferred to the assembly location in Bangkok, Thailand.

**Classification of Change:** The new location (Bangkok, Thailand) has been installed with additional capacity to meet the increasing market demands.

**Expected Influence on Quality/Reliability/Performance:** No influence on quality and reliability expected. Nevertheless, we recommend to test the product in customer's application.

The device from the new location will have some advantages.

Appearance: Notch to identify Pin 1 & Tie-bar design but the package dimensions are exactly the same as our current VCNT2020.

Better performance: Tighter collector current limits to minimize tolerances

More details in the separate slides.

**Part Numbers/Series/Families Affected:** VCNT2020

**Vishay Brand(S):** Vishay Semiconductors

**Time Schedule:**

Start Shipment Date: Sun Jun 4, 2023

**Sample Availability:** 28-FEB-2023

**Product Identification:** datecode and special label

**Qualification Data:** Available upon request



# Product Change Notification



Product Group: OPT/Tue Feb 21, 2023/PCN-OPT-1259-2023-REV-0

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**This PCN is considered approved, without further notification, unless we receive specific customer concerns before Mon May 15, 2023 or as specified by contract.**

**Issued By:** Mohankumar Kannusamy, mohankumar.kannusamy@vishay.com



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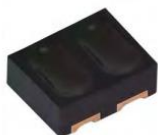
# VCNT2020 Location Transfer

Changes summary

# Change Summary

## Before PCN

- Assembly Location:** Krubong, Malaysia
- Appearance:** No Pin 1 identification available
- Performance:** wider collector current limits



BASIC CHARACTERISTICS (T <sub>amb</sub> = 25 °C, unless otherwise specified)						
PARAMETER	TEST CONDITION	SYMBOL	MIN.	TYP.	MAX.	UNIT
<b>INPUT (EMITTER)</b>						
Forward voltage	I <sub>F</sub> = 20 mA	V <sub>F</sub>	-	1.25	1.4	V
	I <sub>F</sub> = 100 mA		-	1.5	1.7	V
Temperature coefficient of V <sub>F</sub>	I <sub>F</sub> = 20 mA	TKV <sub>F</sub>	-	-1.0	-	mV/K
Peak wavelength	I <sub>F</sub> = 100 mA	λ <sub>p</sub>	-	940	-	nm
Reverse current	V <sub>R</sub> = 5 V	I <sub>R</sub>	-	-	10	μA
<b>OUTPUT (DETECTOR)</b>						
Collector emitter breakdown voltage	I <sub>C</sub> = 0.1 mA, E = 0	V <sub>BRCE</sub>	20	-	-	V
Emitter collector voltage	I <sub>E</sub> = 100 μA, E = 0	V <sub>EC</sub>	7	-	-	V
Collector emitter dark current	V <sub>CE</sub> = 5 V, E = 0	I <sub>CO</sub>	-	1	100	nA
<b>SENSOR</b>						
Collector current	V <sub>CE</sub> = 5 V, I <sub>F</sub> = 20 mA, d = 1 mm	I <sub>C</sub>	0.05	0.1	0.15	mA
Current transfer ratio	I <sub>C</sub> /I <sub>F</sub> , d = 1 mm, V <sub>CE</sub> = 5 V	CTR	-	8	-	%
Rise time	I <sub>C</sub> = 0.8 mA, V <sub>CE</sub> = 5 V, R <sub>L</sub> = 100 Ω	t <sub>r</sub>	-	10	70	μs
Fall time	I <sub>C</sub> = 0.8 mA, V <sub>CE</sub> = 5 V, R <sub>L</sub> = 100 Ω	t <sub>f</sub>	-	15	70	μs

## After PCN

- Assembly Location:** Bangkok, Thailand
- Appearance:** Notch to identify Pin 1 & Tie-bar but the package dimensions are exactly the same
- Performance:** Tighter collector current limits to minimize tolerances



BASIC CHARACTERISTICS (T <sub>amb</sub> = 25 °C, unless otherwise specified)						
PARAMETER	TEST CONDITION	SYMBOL	MIN.	TYP.	MAX.	UNIT
<b>INPUT (EMITTER)</b>						
Forward voltage	I <sub>F</sub> = 20 mA	V <sub>F</sub>	-	1.25	1.4	V
	I <sub>F</sub> = 100 mA		-	1.5	1.7	V
Temperature coefficient of V <sub>F</sub>	I <sub>F</sub> = 20 mA	TKV <sub>F</sub>	-	-1.0	-	mV/K
Peak wavelength	I <sub>F</sub> = 100 mA	λ <sub>p</sub>	-	940	-	nm
Reverse current	V <sub>R</sub> = 5 V	I <sub>R</sub>	-	-	10	μA
<b>OUTPUT (DETECTOR)</b>						
Collector emitter breakdown voltage	I <sub>C</sub> = 0.1 mA, E = 0	V <sub>BRCE</sub>	20	-	-	V
Emitter collector voltage	I <sub>E</sub> = 100 μA, E = 0	V <sub>EC</sub>	7	-	-	V
Collector emitter dark current	V <sub>CE</sub> = 5 V, E = 0	I <sub>CO</sub>	-	1	100	nA
<b>SENSOR</b>						
Collector current	V <sub>CE</sub> = 5 V, I <sub>F</sub> = 20 mA, d = 1 mm	I <sub>C</sub>	0.05	0.1	0.15	mA
Current transfer ratio	I <sub>C</sub> /I <sub>F</sub> , d = 1 mm, V <sub>CE</sub> = 5 V	CTR	-	8	-	%
Rise time	I <sub>C</sub> = 0.8 mA, V <sub>CE</sub> = 5 V, R <sub>L</sub> = 100 Ω	t <sub>r</sub>	-	10	70	μs
Fall time	I <sub>C</sub> = 0.8 mA, V <sub>CE</sub> = 5 V, R <sub>L</sub> = 100 Ω	t <sub>f</sub>	-	15	70	μs



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THANK YOU